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Tel: +86-755-8981 8866 Fax: +86-755-8427 6832 Email & Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China



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STL10LN80K5

N-channel 800 V, 0.59 Ω typ., 6 A MDmesh™ K5 Power MOSFET in a PowerFLAT™ 5x6 VHV package

Datasheet - production data

Features

Order code	V _{DS}	R _{DS(on)} max.	ID
STL10LN80K5	800 V	0.66 Ω	6 A

- Industry's lowest R_{DS(on)} x area
- Industry's best figure of merit (FoM)
- Ultra-low gate charge
- 100% avalanche tested
- Zener-protected

Applications

• Switching applications

Description

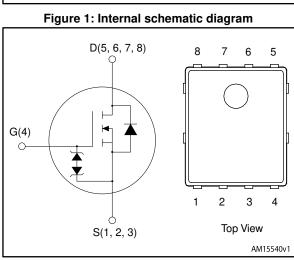
This very high voltage N-channel Power MOSFET is designed using MDmesh[™] K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

Table 1: Device summary

Order code	Marking	Package	Packing
STL10LN80K5	10LN80K5	PowerFLAT™ 5x6 VHV	Tape and reel

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This is information on a product in full production.



PowerFLAT™ 5x6 VHV	

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1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{GS}	Gate-source voltage	± 30	V
ID	Drain current (continuous) at $T_c = 25 \text{ °C}$	6	А
ID	Drain current (continuous) at T _c = 100 °C	3.8	А
ا _D ⁽¹⁾	Drain current pulsed	24	А
P _{TOT}	Total dissipation at $T_C = 25 \text{ °C}$	42	W
dv/dt ⁽²⁾	Peak diode recovery voltage slope	4.5	
dv/dt ⁽³⁾	MOSFET dv/dt ruggedness	50	V/ns
Tj	Operating junction temperature range	55 to 150	°C
T _{stg}	Storage temperature range	- 55 to 150	÷C

Notes:

 $^{(1)}\mbox{Pulse}$ width limited by safe operating area

 $^{(2)}I_{SD} \leq 6$ A, dv/dt ≤ 100 A/µs; V_Ds peak $< V_{(BR)DSS},$ V_DD=640 V

 $^{(3)}V_{DS} \le 640 \text{ V}$

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	3	°C/W
Rthj-amb ⁽¹⁾	Thermal resistance junction-ambient	59	°C/W

Notes:

 $^{(1)}\!When$ mounted on 1inch² FR-4 board, 2 oz Cu

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
lar	Avalanche current, repetitive or not repetitive (pulse width limited by T_{jmax})	2.7	А
E _{AS}	Single pulse avalanche energy (starting T_j = 25 °C, I_D = I_{AR},V_{DD} = 50 V)	240	mJ



2 Electrical characteristics

 $T_C = 25$ °C unless otherwise specified

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	V_{GS} = 0 V, I_{D} = 1 mA	800			V
I _{DSS}	Zero gate voltage drain current	$V_{GS} = 0 V, V_{DS} = 800 V$			1	μA
		$V_{GS} = 0 V, V_{DS} = 800 V$ $T_{C} = 125 \text{ °C}^{(1)}$			50	μA
I _{GSS}	Gate body leakage current	$V_{\text{DS}} = 0 \ V, \ V_{\text{GS}} = \pm 20 \ V$			±10	μA
V _{GS(th)}	Gate threshold voltage	$V_{\text{DS}} = V_{\text{GS}}, \ I_{\text{D}} = 100 \ \mu\text{A}$	3	4	5	V
R _{DS(on)}	Static drain-source on-resistance	$V_{GS}=10~V,~I_{D}=4~A$		0.59	0.66	Ω

Table 5: On/off-state

Notes:

⁽¹⁾Defined by design, not subject to production test.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	427	-	pF
C _{oss}	Output capacitance	$V_{DS} = 100 \text{ V}, \text{ f} = 1 \text{ MHz},$ $V_{GS} = 0 \text{ V}$	-	43	-	pF
C _{rss}	Reverse transfer capacitance	VGS = 0 V	-	0.25	-	pF
C _{o(tr)} ⁽¹⁾	Equivalent capacitance time related	V _{DS} = 0 to 640 V,	-	72	-	рF
C _{o(er)} ⁽²⁾	Equivalent capacitance energy related	$V_{GS} = 0 V$		27	-	pF
Rg	Intrinsic gate resistance	$f = 1 \text{ MHz}$, $I_D = 0 \text{ A}$	-	7	-	Ω
Qg	Total gate charge	$V_{DD} = 640 \text{ V}, \text{ I}_{D} = 8 \text{ A}$	-	15	-	nC
Q _{gs}	Gate-source charge	V_{GS} = 10 V	-	4.2	-	nC
Q _{gd}	Gate-drain charge	(see Figure 16: "Test circuit for gate charge behavior")	-	9	-	nC

Table 6: Dynamic

Notes:

 $^{(1)}$ Time related is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

 $^{(2)}$ Energy related is defined as a constant equivalent capacitance giving the same stored energy as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}



Electrical characteristics

Table 7: Switching times							
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
t _{d(on)}	Turn-on delay time	V_{DD} = 400 V, I_D = 4 A, R_G = 4.7 Ω	-	11.8	-	ns	
tr	Rise time	V _{GS} = 10 V (see <i>Figure 15: "Test</i>	-	10	-	ns	
t _{d(off)}	Turn-off delay time	circuit for resistive load switching times" and Figure 20: "Switching	-	28	-	ns	
t _f	Fall time	time waveform')	-	13	-	ns	

Table 8: Source-drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		6	А
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		24	А
V _{SD} ⁽²⁾	Forward on voltage	$I_{SD}=6~A,~V_{GS}=0~V$	-		1.5	V
t _{rr}	Reverse recovery time	$I_{SD} = 6 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$ $V_{DD} = 60 \text{ V}$ (see Figure 17: "Test circuit for inductive load switching and diode recovery times")	-	350		ns
Qrr	Reverse recovery charge		-	3.9		μC
I _{RRM}	Reverse recovery current		-	22.5		А
t _{rr}	Reverse recovery time	$I_{SD} = 6 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	505		ns
Qrr	Reverse recovery charge	$V_{DD} = 60 \text{ V}, \text{ T}_{j} = 150 \text{ °C}$ (see <i>Figure 17: "Test circuit</i>	-	5		μC
I _{RRM}	Reverse recovery current	for inductive load switching and diode recovery times")	-	20		А

Notes:

 $^{(1)}\mbox{Pulse}$ width limited by safe operating area

 $^{(2)}$ Pulsed: pulse duration = 300 µs, duty cycle 1.5%

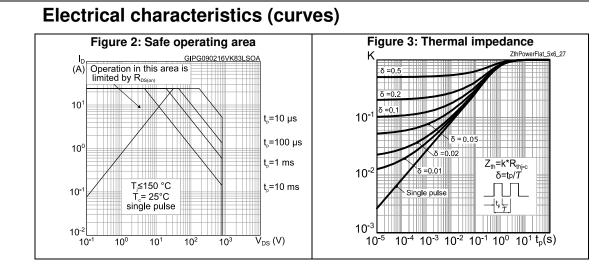
Table 9: Gate-source Zener diode

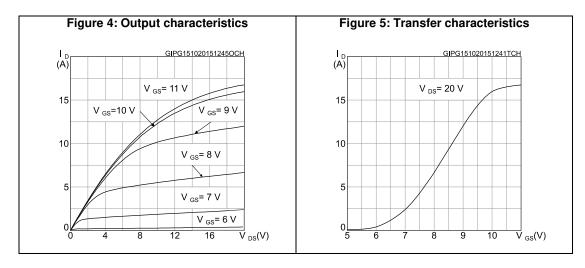
Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
V (BR)GSO	Gate-source breakdown voltage	I_{GS} = ± 1 mA, I_{D} = 0 A	30	-	-	V

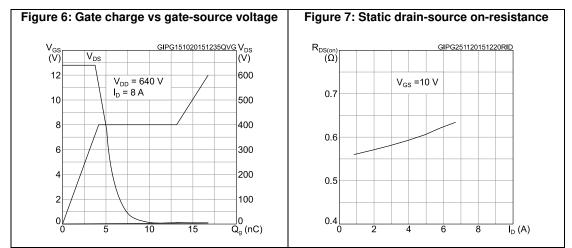
The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.



2.2



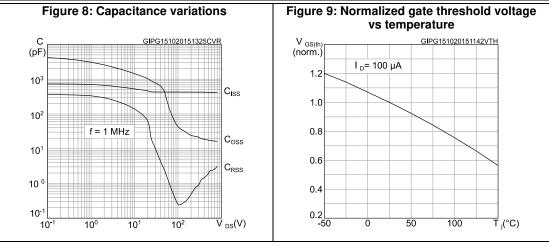


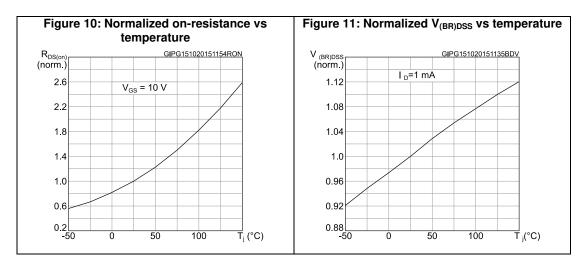


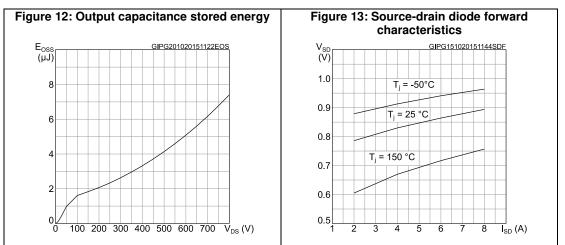
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Electrical characteristics



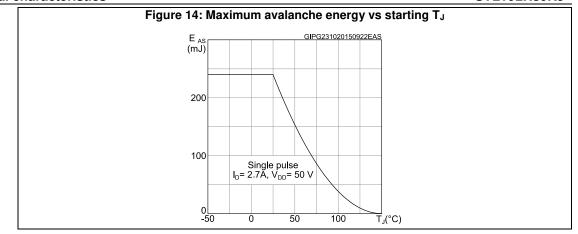






Electrical characteristics

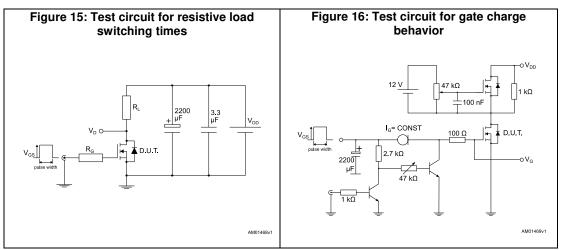
STL10LN80K5

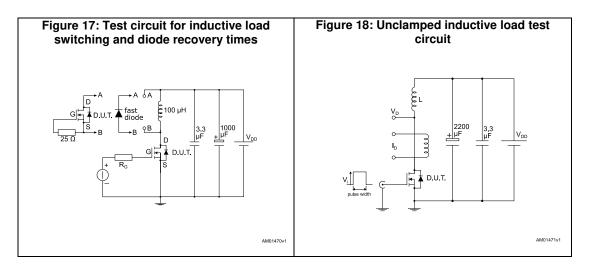


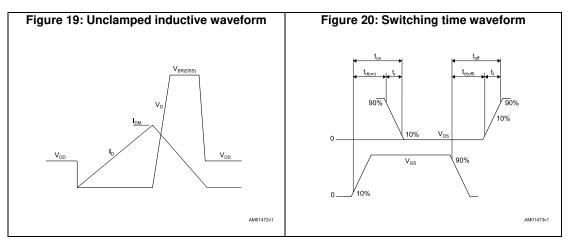
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3 Test circuits









4 Package information

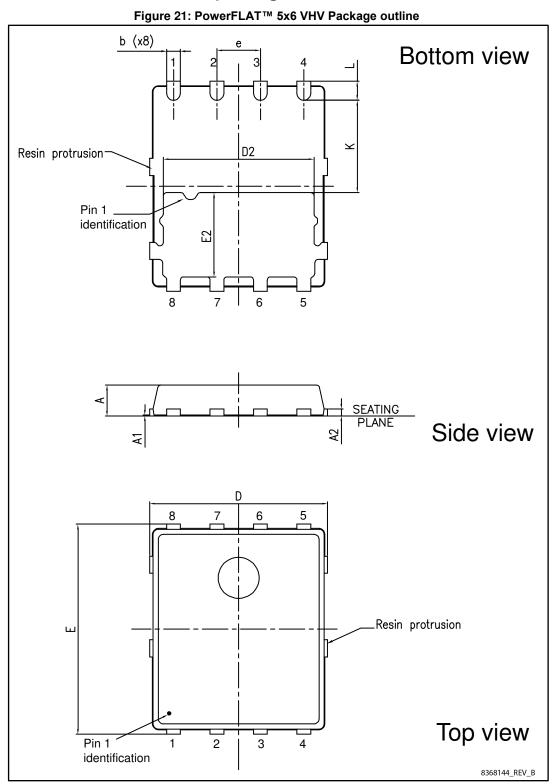
In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.



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Package information





DocID027748 Rev 2

Package information

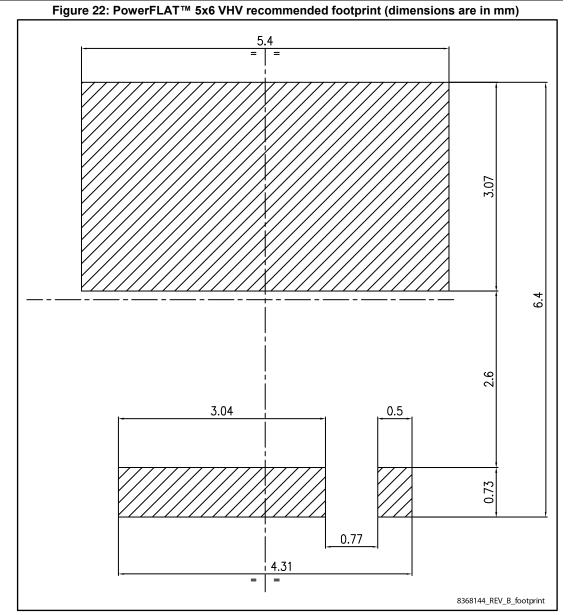
Table 10: PowerFLAT[™] 5x6 VHV package mechanical data

STL10LN80K5

Table 10. Fowert LAT 5x0 VITV package mechanical data				
Dim.	mm			
	Min.	Тур.	Max.	
A	0.80		1.00	
A1	0.02		0.05	
A2		0.25		
b	0.30		0.50	
D	5.00	5.20	5.40	
E	5.95	6.15	6.35	
D2	4.30	4.40	4.50	
E2	2.40	2.50	2.60	
е		1.27		
L	0.50	0.55	0.60	
К	2.60	2.70	2.80	



Package information





4.2 PowerFLAT[™] 5x6 packing information

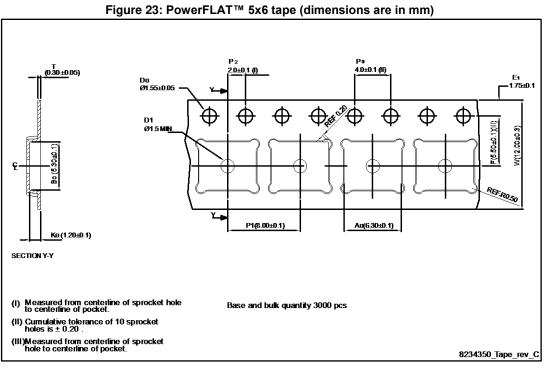
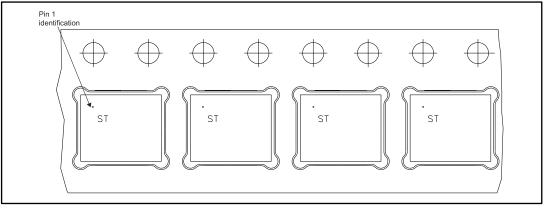
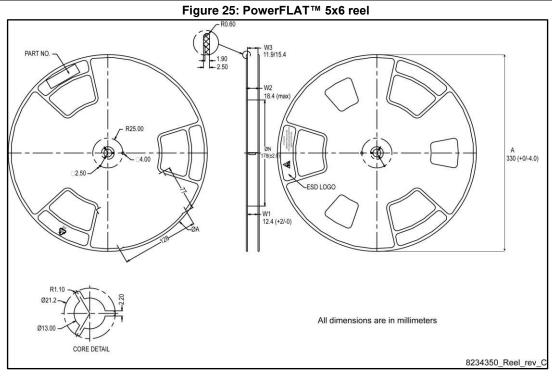


Figure 24: PowerFLAT™ 5x6 package orientation in carrier tape





Package information





Revision history 5

Table 11: Document revision history

Date	Revision	Changes
25-Sep-2015	1	First release.
09-Feb-2016	2	Modified: R _{DS(on)} in cover page Modified: <i>Table 2: "Absolute maximum ratings"</i> , <i>Table 3: "Thermal data"</i> , <i>Table 5: "On/off-state"</i> , <i>Table 6: "Dynamic"</i> and <i>Table 8: "Source-drain diode"</i> Added: <i>Section 3.1: "Electrical characteristics (curves)"</i> Minor text changes



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